

ALLPCB

MICROSECTION INSPECTION REPORT

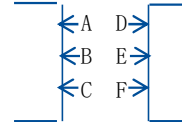
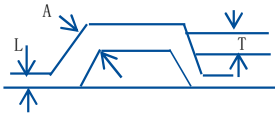
1. Thickness Measurements of Copper, Solder, Solder Mask (Unit: um)

Items		Hole Wall Cu						Solder Thickness		Solder Mask		
		A	B	C	D	E	F	Hole (avg.)	SMT	A	T	L
Requirement		MI Requirement $\geq 20\mu\text{m}$						$\geq 1-40\mu\text{m}$		≥ 10	≥ 10	≥ 10
Result	#1	21.5	23.7	22.0	21.0	23.2	22.8	6.25		15.6	17.3	16.4
	#2											
	#2											

Solder Mask

Specimen Locations

Hole Wall Cu, Solder



2. Thickness Measurement of Copper (Internal and Outer Layers) (Unit:um)

Layer	L1	L2	L3	L4	L5	L6	L7	L8	L9	L10	L11	L12
Requirement	/	/	/	/	/	/	/	/	/	/	/	/
Result	#1	/	/	/	/	/	/	/	/	/	/	/
	#2	/	/	/	/	/	/	/	/	/	/	/

3. Measurements of Drilling Roughness and Dielectric Thickness (Unit: mm)

Item		Roughness	Dielectric Thickness									
Requirement		≤ 25.4		/	/							
Result	#1	15.60			/							
	#2	17.30										
	#3	16.80										

4. Defects Inspection

Item	Pass	Fail
Smear	ACC	
Plating Void	ACC	
Plating Crack	ACC	
Burrs and Nodules	ACC	
Glass Fiber Protrusion	ACC	
Pad Lifted Land	ACC	
Separation Between Layers	ACC	
Pull Away of Hole Copper	ACC	
Connection Separation Between internal Layer	ACC	

Remarks:

Disposition:	◆C	RE◆
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QA Inspected By:

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